



YEA SHIN TECHNOLOGY CO., LTD

YS2305

P-Channel Enhancement MOSFET

VDS= -20V, ID= -4.2A



DESCRIPTION

The YS2305 is the highest performance trench P-Ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the small power switching and load switch applications.

The YS2305 meet the RoHS and Green Product requirement with full function reliability approved.

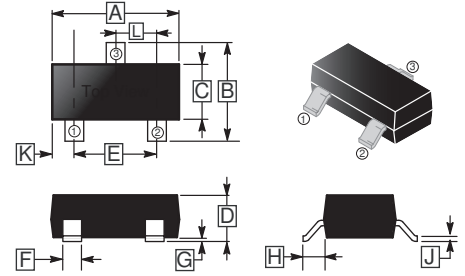
FEATURES

- Advanced High Cell Density Trench Technology
- Super Low Gate Charge

MARKING

2305

SC-59



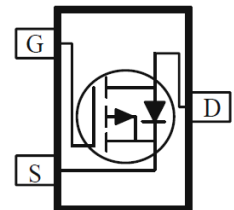
REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	0.10 REF.	
B	2.10	3.00	H	0.40 REF.	
C	1.20	1.70	J	0.047	0.207
D	0.89	1.40	K	0.5 REF.	
E	2.00 Typ.		L	0.95 REF.	
F	0.30	0.50			

PACKAGE INFORMATION

Package	MPQ	Leader Size
SC-59	3K	7 inch

ORDER INFORMATION

Part Number	Type
YS2305	Lead (Pb)-free and Halogen-free



ABSOLUTE MAXIMUM RATINGS

Parameter		Symbol	Ratings		Unit
			≤ 10sec	Steady State	
Drain-Source Voltage		V _{DS}	-20		V
Gate-Source Voltage		V _{GS}	±12		V
Drain Current ¹ , @VGS= -10V	T _A =25°C	I _D	-4.2	-3.7	A
	T _A =70°C		-3.5	-3	
Pulsed Drain Current ³		I _{DM}	-30		A
Power Dissipation	T _A =25°C	P _D	1.4		W
Operating Junction and Storage Temperature Range		T _J , T _{STG}	-55~150		°C
Thermal Resistance Data					
Thermal Resistance Junction-Ambient ¹		R _{θJA}	≤ 10sec, 90		°C/W
			Steady State, 125		
Thermal Resistance Junction-Ambient ²			270		
Thermal Resistance Junction-Case ¹		R _{θJC}	80		

YS2305

ELECTRICAL CHARACTERISTICS (T_J=25°C unless otherwise specified)

Parameter		Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage		BV _{DSS}	-20	-	-	V	V _{GS} =0, I _D = -250μA
Gate Threshold Voltage		V _{GS(th)}	-0.5	-	-1.2	V	V _{DS} =V _{GS} , I _D = -250μA
Forward Transconductance		g _{fs}	-	5.6	-	S	V _{DS} = -5V, I _D = -3A
Gate-Source Leakage Current		I _{GSS}	-	-	±100	nA	V _{GS} = ±12V
Drain-Source Leakage Current	T _J =25°C	I _{DSS}	-	-	-1	μA	V _{DS} = -20V, V _{GS} =0
	T _J =55°C		-	-	-5		V _{DS} = -20V, V _{GS} =0
Drain-Source On-Resistance ⁴		R _{DS(ON)}	-	-	53	mΩ	V _{GS} = -10V, I _D = -4.5A
			-	-	65		V _{GS} = -4.5V, I _D = -4.2A
			-	-	100		V _{GS} = -2.5V, I _D = -2A
			-	-	250		V _{GS} = -1.8V, I _D = -1A
Total Gate Charge		Q _g	-	11.9	-	nC	I _D = -3A
Gate-Source Charge		Q _{gs}	-	1.8	-		V _{DS} = -15V
Gate-Drain (“Miller”) Charge		Q _{gd}	-	3	-		V _{GS} = -4.5V
Turn-on Delay Time		T _{d(on)}	-	6.6	-	nS	V _{DD} = -15V
Rise Time		T _r	-	27.8	-		V _{GS} = -4.5V
Turn-off Delay Time		T _{d(off)}	-	46.2	-		I _D = -3A
Fall Time		T _f	-	20.6	-		R _G =3.3Ω R _L =5Ω
Input Capacitance		C _{iss}	-	920	-	pF	V _{GS} =0
Output Capacitance		C _{oss}	-	73	-		V _{DS} = -15V
Reverse Transfer Capacitance		C _{rss}	-	71	-		f=1MHz
Source-Drain Diode							
Forward on Voltage ⁴		V _{SD}	-	-	-1.2	V	I _S = -1.2A, V _{GS} =0
Continuous Source Current ¹		I _S	-	-	-3.7	A	
Pulsed Source Current ³		I _{SM}	-	-	-15		

Notes:

1. Surface mounted on a 1 inch² FR-4 board with 20Z copper.
2. When mounted on Min. copper pad.
3. Pulse width limited by maximum junction temperature.
4. The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%.

DEVICE CHARACTERISTICS

YS2305

CHARACTERISTIC CURVE

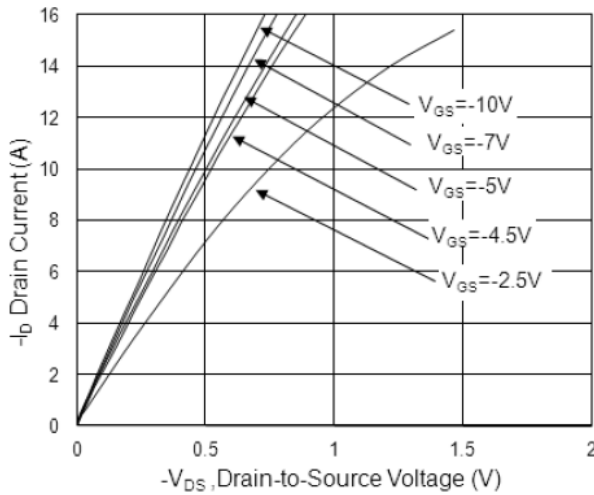


Fig.1 Typical Output Characteristics

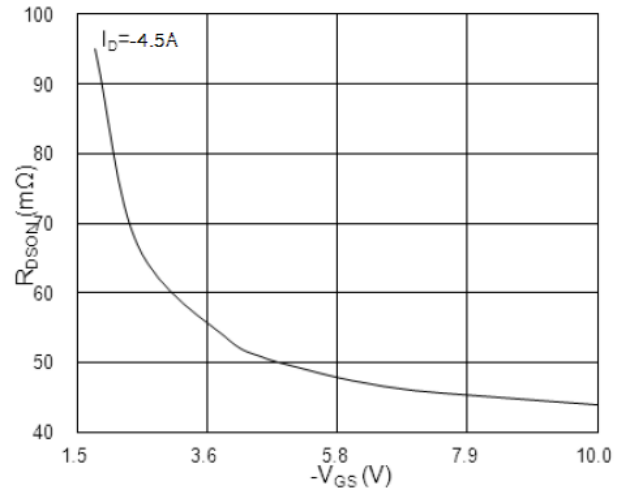


Fig.2 On-Resistance vs. G-S Voltage

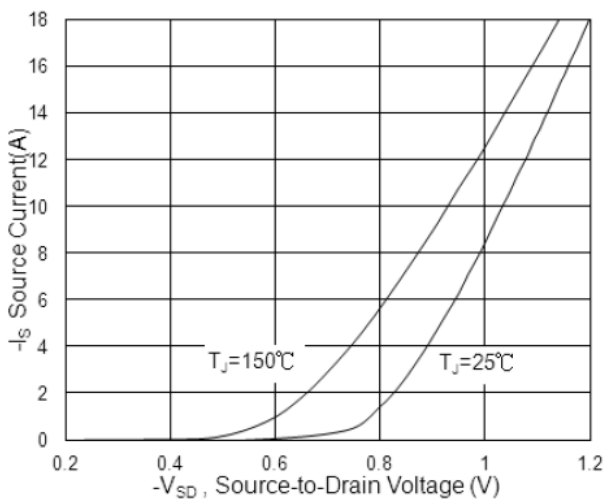


Fig.3 Forward Characteristics Of Reverse

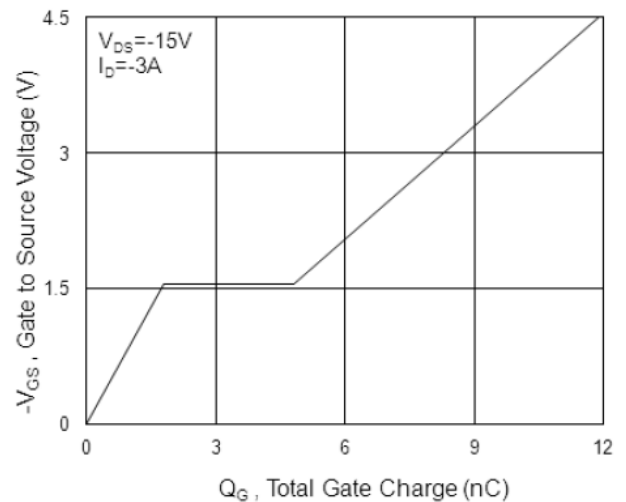


Fig.4 Gate-Charge Characteristics

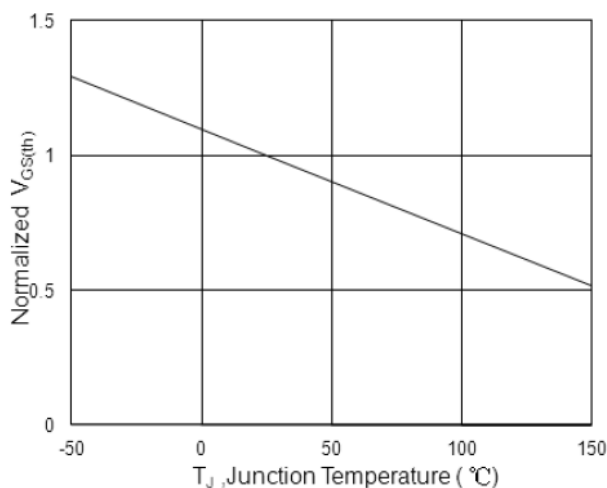


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

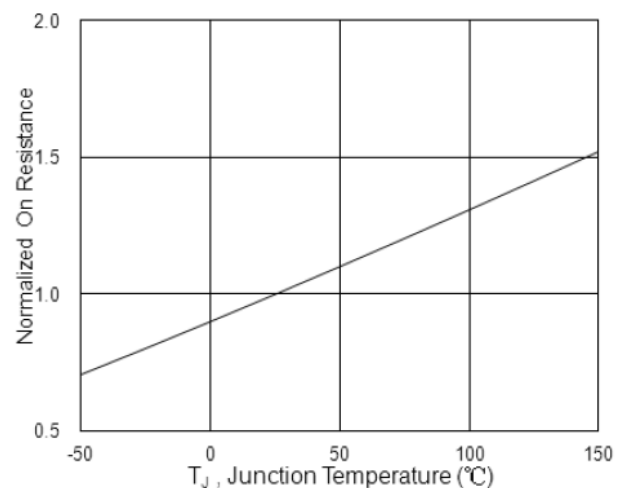


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

DEVICE CHARACTERISTICS

YS2305

CHARACTERISTIC CURVE

